

<b>Notice of References Cited</b>	Application/Control No. 10/599,894		Applicant(s)/Patent Under Reexamination MAINWARING ET AL.	
	Examiner JONATHAN DUNLAP		Art Unit 2855	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Fink et al. "Conductivity of Aged Non-Overlapping and Overlapping Tracks in Ion Irradiated Polyimide". Radiation Measurements, Volume 25, Issues 1-4, 1995, Pages 51-54.
	V	Svorcik et al. "Degradation of Polyimide by Implantation with Ar <sup>+</sup> ions". Journal of Applied Polymer Science, Volume 64, Issue 4 , Pages 723 - 728, Published Online: 7 Dec 1998
	W	Lin et al. "Preparation and Properties of Conductive Polyimide Films". Journal of Polymer Research, Issue 9, Pages 189-194, 2002
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.